Current-Mode PWM Controller for Off-line Power Supplies

The NCP1251 is a highly integrated PWM controller capable of delivering a rugged and high performance offline power supply in a tiny TSOP-6 package. With a supply range up to 28 V, the controller hosts a jittered 65 kHz or 100 kHz switching circuitry operated in peak current mode control. When the power on the secondary side starts to decrease, the controller automatically folds back its switching frequency down to a minimum level of 26 kHz. As the power further goes down, the part enters skip cycle while limiting the peak current.

Over Power Protection (OPP) is a difficult exercise especially when no–load standby requirements drive the converter specifications. The ON proprietary integrated OPP lets you harness the maximum delivered power without affecting your standby performance simply via two external resistors. A latched Over Voltage Protection (OVP) is combined on the same pin. For ease of implementation, a latched OVP also monitors the $V_{\rm CC}$ line. They offer an efficient protection in case of optocoupler destruction or adverse open loop operation.

Finally, a timer-based short-circuit protection offers the best protection scheme, letting you precisely select the protection trip point irrespective of a loose coupling between the auxiliary and the power windings.

Features

- Fixed-Frequency 65 or 100 kHz Current-Mode Control Operation
- Internal and Adjustable Over Power Protection (OPP) Circuit
- Frequency Foldback Down to 26 kHz and Skip-Cycle in Light Load Conditions
- Internal Ramp Compensation
- Internal Fixed 4 ms Soft-Start
- 100 ms Timer-Based Auto-Recovery Short-Circuit Protection
- Frequency Jittering in Normal and Frequency Foldback Modes
- Option for Auto-Recovery or Latched Short-Circuit Protection
- OVP Input for Improved Robustness
- Up to 28 V V_{CC} Operation
- Latched or Auto-Recovery OVP Protection on V_{CC}
- +300 mA / -500 mA Source/Sink Drive Capability
- Less than 100 mW Standby Power at High Line
- EPS 2.0 Compliant
- These are Pb-Free Devices

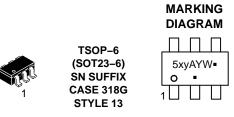
Typical Applications

- ac-dc Converters for TVs, Set-top Boxes and Printers
- Offline Adapters for Notebooks and Netbooks



ON Semiconductor®

www.onsemi.com



5xy = Specific Device Code

c = A or U

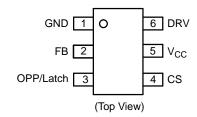
= A, 2, C, D, or F = Assembly Location

Y = Year W = Work Week

= Pb-Free Package

(Note: Microdot may be in either location)

PIN CONNECTIONS



ORDERING INFORMATION

See detailed ordering, marking and shipping information on page 2 of this data sheet.

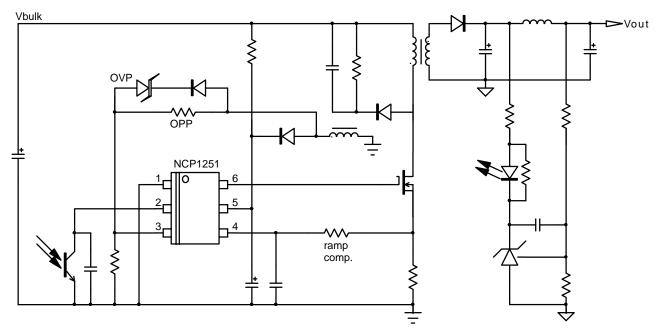


Figure 1. Typical Application Example

Pin N°	Pin Name	Function	Pin Description
1	GND	-	The controller ground.
2	FB	Feedback pin	Hooking an optocoupler collector to this pin will allow regulation.
3	OPP/OVP	Adjust the Over Power Protection Latches off the part	A resistive divider from the auxiliary winding to this pin sets the OPP compensation level. When brought above 3 V, the part is fully latched off.
4	CS	Current sense + ramp compensation	This pin monitors the primary peak current but also offers a means to introduce ramp compensation.
5	V _{CC}	Supplies the controller	This pin is connected to an external auxiliary voltage and supplies the controller. When the V _{CC} exceeds a certain level, the part permanently latches off.
6	DRV	Driver output	The driver's output to an external MOSFET gate.

OPTIONS

Controller	Frequency	OCP	V _{CC} OVP	OVP/OTP
NCP1251ASN65T1G	65 kHz	Latched	Latched	Latched
NCP1251BSN65T1G	65 kHz	Autorecovery	Latched	Latched
NCP1251CSN65T1G	65 kHz	Autorecovery	Autorecovery	Latched
NCP1251FSN65T1G	65 kHz	Autorecovery	Latched	Latched
NCP1251ASN100T1G	100 kHz	Latched	Latched	Latched
NCP1251BSN100T1G	100 kHz	Autorecovery	Latched	Latched

NOTE: F version has a different foldback scheme for improved efficiency.

ORDERING INFORMATION

Device	Package Marking	OCP Protection	V _{CC} OVP Protection	Switching Frequency	Package	Shipping [†]
NCP1251ASN65T1G	5AA	Latch	Latch	65 kHz		
NCP1251BSN65T1G	5A2	Autorecovery	Latch	65 kHz		3000 /
NCP1251CSN65T1G	5AE	Autorecovery	Autorecovery	65 kHz	TSOP-6	
NCP1251FSN65T1G	5AF	Autorecovery	Latch	65 kHz	(Pb-Free)	Tape & Reel
NCP1251ASN100T1G	5AC	Latch	Latch	100 kHz		
NCP1251BSN100T1G	5AD	Autorecovery	Latch	100 kHz		

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

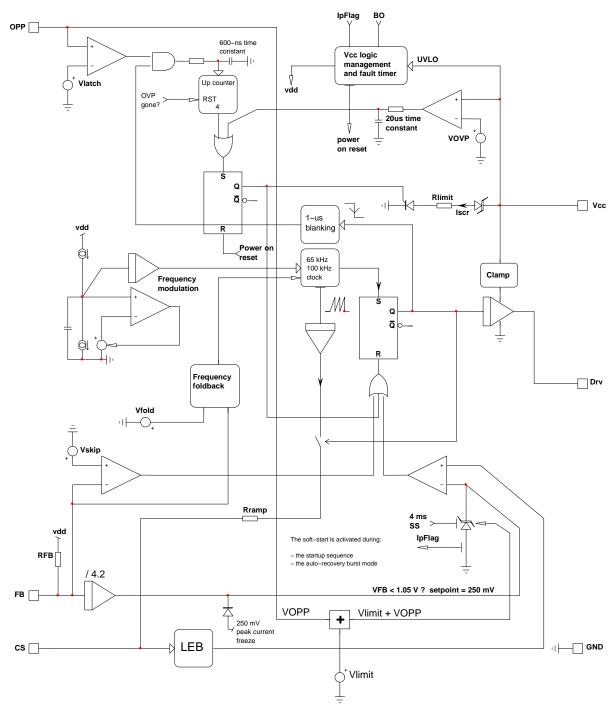


Figure 2. Internal Circuit Architecture

MAXIMUM RATINGS TABLE

Symbol	Rating	Value	Unit
V _{CC}	Power Supply voltage, V _{CC} pin, continuous voltage	28	V
V _{DRVtran}	Maximum DRV pin voltage when DRV in H state, transient voltage (Note 1)	V _{CC} + 0.3	V
	Maximum voltage on low power pins CS, FB and OPP	-0.3 to 10	V
IOPP	Maximum injected negative current into the OPP pin (pin 3)	-2	mA
I _{SCR}	Maximum continuous current into the V _{CC} pin while in latch mode	3	mA
$R_{\theta JA}$	Thermal Resistance Junction-to-Air	360	°C/W
$T_{J,max}$	Maximum Junction Temperature	150	°C
	Storage Temperature Range	-60 to +150	°C
	ESD Capability, Human Body Model (HBM), all pins	2	kV
	ESD Capability, Machine Model (MM)	200	V
	ESD Capability, Charged Device Model (CDM)	1	kV

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

- The transient voltage is a voltage spike injected to DRV pin being in high state. Maximum transient duration is 100 ns.
 This device series contains ESD protection and exceeds the following tests: Human Body Model 2000 V per JESD22, Method A114E. Machine Model Method 200 V per JESD22, Method A115A. Charged Device Model per JEDEC Standard JESD22–C101D
 This device contains latch-up protection and exceeds 100 mA per JEDEC Standard JESD78.

ELECTRICAL CHARACTERISTICS

(For typical values $T_J = 25^{\circ}C$, for min/max values $T_J = -40^{\circ}C$ to $+125^{\circ}C$, Max $T_J = 150^{\circ}C$, $V_{CC} = 12$ V unless otherwise noted)

$\begin{array}{cccccccccccccccccccccccccccccccccccc$	Symbol	Rating	Pin	Min	Тур	Max	Unit	
$ \begin{array}{c} VCC_{(min)} \\ VCC_{(m$	SUPPLY SECTION							
$ \begin{array}{c} VC_{CHYST} \\ Vz_{ENER} \\ Vz_{ENER} \\ Clamped V_{CC} \ when latched off / burst mode activation @ I_{CC} = 500 \mu\text{A} \\ 5 \\ \hline V_{ZENER} \\ Clamped V_{CC} \ when latched off / burst mode activation @ I_{CC} = 500 \mu\text{A} \\ \hline Start-up current \\ \hline ICC2 \\ Internal IC consumption with I_{FB} = 50 \mu\text{A}, F_{SW} = 65 kHz \ and C_L = 0 nF \\ \hline S \\ \hline ICC3 \\ Internal IC consumption with I_{FB} = 50 \mu\text{A}, F_{SW} = 65 kHz \ and C_L = 1 nF \\ \hline S \\ \hline ICC2 \\ Internal IC consumption with I_{FB} = 50 \mu\text{A}, F_{SW} = 100 kHz \ and C_L = 1 nF \\ \hline S \\ \hline ICC3 \\ Internal IC consumption with I_{FB} = 50 \mu\text{A}, F_{SW} = 100 kHz \ and C_L = 1 nF \\ \hline S \\ \hline ICC3 \\ Internal IC consumption with I_{FB} = 50 \mu\text{A}, F_{SW} = 100 kHz \ and C_L = 1 nF \\ \hline ICC3 \\ \hline INTERNAL \\ \hline ICC3 \\ \hline INTERNAL \\ \hline ICC3 \\ \hline INTERNAL \\ \hline INTERNAL \\ \hline ICC3 \\ \hline INTERNAL \\ \hline INTERNAL \\ \hline ICC3 \\ \hline INTERNAL \\ \hline INTERNAL \\ \hline ICC3 \\ \hline INTERNAL \\ \hline I$	VCC _{ON}	V _{CC} increasing level at which driving pulses are authorized	5	16	18	20	V	
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	VCC _(min)	V _{CC} decreasing level at which driving pulses are stopped	5	8.2	8.8	9.4	V	
ICC1 Start-up current	VCC _{HYST}	Hysteresis VCC _{ON} – VCC _(min)	5	6.0			V	
Internal IC consumption with $I_{FB} = 50 \mu\text{A}$, $F_{SW} = 65 \text{kHz}$ and $C_L = 0 \text{nF}$ 5	V _{ZENER}	Clamped V_{CC} when latched off / burst mode activation @ I_{CC} = 500 μA	5		7.0		V	
Incc3 Internal IC consumption with I $_{FB} = 50$ μA, $F_{SW} = 65$ kHz and $C_L = 1$ nF 5 2.1 IncC2 Internal IC consumption with I $_{FB} = 50$ μA, $F_{SW} = 100$ kHz and $C_L = 0$ nF 5 1.7 ICC3 Internal IC consumption with I $_{FB} = 50$ μA, $F_{SW} = 100$ kHz and $C_L = 1$ nF 5 3.3.1 ICCstby Internal IC consumption while in skip cycle ($V_{CC} = 12$ V, driving a typical 6 A/600 V 5 550 MOSFET) ICCLATCH Current flowing into V_{CC} pin that keeps the controller latched (Note 4) $T_{J} = -40^{\circ}$ C to +125°C $T_{J} = 0^{\circ}$ C to	ICC1	Start-up current	5			15	μΑ	
ICC2 Internal IC consumption with $I_{BB} = 50 \mu A$, $F_{SW} = 100 kHz$ and $C_L = 0 nF$ 5 1.7 ICC3 Internal IC consumption with $I_{FB} = 50 \mu A$, $F_{SW} = 100 kHz$ and $C_L = 1 nF$ 5 3.1 ICCstby Internal IC consumption while in skip cycle ($V_{CC} = 12 V$, driving a typical 6 A/600 V MOSFET) Internal IC consumption while in skip cycle ($V_{CC} = 12 V$, driving a typical 6 A/600 V MOSFET) 5 40 32 ICCLATCH Current flowing into V_{CC} pin that keeps the controller latched (Note 4) 5 4.0 DRIVE OUTPUT Tr Cutput voltage rise—time @ $C_L = 1 nF$, 10–90% of output signal 6 4 6 40 Tr Output voltage rise—time @ $C_L = 1 nF$, 10–90% of output signal 6 4 6 30 ROH Source resistance 6 13 ROH Source resistance 6 6 6.0 In 30 ROH Source externet, $V_{GS} = 0 V - (Note 5)$ 6 6 300 Isink Peak sink current, $V_{GS} = 0 V - (Note 5)$ 6 8.0 For VDRVIology DRV pin level at V_{CC} close to V_{CC} (min) with a 33 kΩ resistor to GND 6 8.0 In 30 CURRENT COMPARATOR Ilb Input Bias Current @ 0.8 V input level on pin 4 4 0.02 VLimit1 Maximum internal current setpoint $-T_J = 25^{\circ}C - pin 3$ grounded 4 0.744 0.8 VInput Ide Default internal voltage set point for frequency foldback trip point -45% of V_{limit} 9 Avimum internal current setpoint $-T_J = -40^{\circ}C$ to $125^{\circ}C - pin 3$ grounded 4 0.72 0.8 VInetage Internal peak current setpoint frequency foldback trip point -45% of V_{limit} 3 3.357 VInces Propagation delay from current detection to gate off-state 4 100 To Equation 100Pv Voltage setpoint for pin 3 biased to $-250 mV - (Note 6)$ 7, $J_J = 25^{\circ}C$ 3 0.550 Notage setpoint for pin 3 biased to $-250 mV - (Note 6)$ 7, $J_J = 25^{\circ}C$ 3 0.550 Notage setpoint for pin 3 biased to $-250 mV - (Note 6)$ 7, $J_J = 25^{\circ}C$ 3 0.551 0.550 Notage setpoint for pin 3 biased to $-250 mV - (Note 6)$ 7, $J_J = 25^{\circ}C$ 3 0.551 0.550	ICC2	Internal IC consumption with I $_{FB}$ = 50 $\mu A,F_{SW}$ = 65 kHz and C_L = 0 nF	5		1.4	2.2	mA	
ICC3 Internal IC consumption with $I_{FB} = 50 \mu A$, $F_{SW} = 100 kHz$ and $C_L = 1 nF$ 5 3.1 ICCstby Internal IC consumption while in skip cycle ($V_{CC} = 12 V$, driving a typical 6 A/600 V MOSFET) 5 550 ICC_LATCH Current flowing into V_{CC} pin that keeps the controller latched (Note 4) $T_J = -40^{\circ}C$ to +125°C $T_J = -40^{\circ}C$ to +125°C $T_J = -40^{\circ}C$ to +125°C 5 4.0 Riim Current-limit resistor in series with the latch SCR 5 4.0 DRIVE OUTPUT Tr Output voltage rise—time @ $C_L = 1 nF$, 10–90% of output signal 6 40 Tf Output voltage fall—time @ $C_L = 1 nF$, 10–90% of output signal 6 30 R_{OH} Source resistance 6 13 R_{OL} Sink resistance 6 6 I_{source} Peak source current, $V_{GS} = 0 V - (\text{Note 5})$ 6 300 I_{sink} Peak sink current, $V_{GS} = 12 V - (\text{Note 5})$ 6 8.0 V_{DRVlow} DRV pin level at V_{CC} close to $V_{CC(min)}$ with a 33 k Ω resistor to GND 6 8.0 $V_{DRVhigh}$ DRV pin level at $V_{CC} = 28 V - DRV$ unloaded 6 10 12 CURREN	ICC3	Internal IC consumption with I $_{FB}$ = 50 $\mu A,F_{SW}$ = 65 kHz and C_L = 1 nF	5		2.1	3.0	mA	
ICCstby Internal IC consumption while in skip cycle ($V_{CC} = 12 \text{ V}$, driving a typical 6 A/600 V MOSFET) 5 550 ICCLATCH Current flowing into V_{CC} pin that keeps the controller latched (Note 4) $T_J = -40^{\circ}\text{C}$ to +125°C $T_J = $	ICC2	Internal IC consumption with I_{FB} = 50 μ A, F_{SW} = 100 kHz and C_L = 0 nF	5		1.7	2.5	mA	
$ \begin{array}{c} \text{MOSFET} \rangle \\ \text{ICC}_{LATCH} \\ \text{Current flowing into V}_{CC} \text{ pin that keeps the controller latched (Note 4)} \\ T_{J} = -40^{\circ}\text{C to +125^{\circ}\text{C}} \\ T_{J} = 0^{\circ}\text{C to +125^{\circ}\text{C}} \\ T_{J} = 0^{\circ}$	ICC3	Internal IC consumption with I_{FB} = 50 μ A, F_{SW} = 100 kHz and C_L = 1 nF	5		3.1	4.0	mA	
$T_J = -40^{\circ}\text{C to } +125^{\circ}\text{C} \\ T_J = 0^{\circ}\text{C to } +125^{\circ}\text{C} \\ 32 \\ \end{bmatrix}$ $R_{lim} \text{Current-limit resistor in series with the latch SCR} \qquad 5 \qquad 4.0 \\ \textbf{DRIVE OUTPUT} \\ T_r \text{Output voltage rise-time @ C_L = 1 nF, } 10-90\% \text{ of output signal} \qquad 6 \qquad 40 \\ T_f \text{Output voltage fall-time @ C_L = 1 nF, } 10-90\% \text{ of output signal} \qquad 6 \qquad 30 \\ R_{OH} \text{Source resistance} \qquad 6 \qquad 13 \\ R_{OL} \text{Sink resistance} \qquad 6 \qquad 6 \qquad 6.0 \\ I_{source} \text{Peak source current, } V_{GS} = 0 \text{ V} - (\text{Note } 5) \qquad 6 \qquad 300 \\ I_{sink} \text{Peak sink current, } V_{GS} = 12 \text{ V} - (\text{Note } 5) \qquad 6 \qquad 500 \\ V_{DRVlow} \text{DRV pin level at } V_{CC} \text{ close to } VCC_{(min)} \text{ with a } 33 \text{ k}\Omega \text{ resistor to GND} \qquad 6 \qquad 8.0 \\ V_{DRVloigh} \text{DRV pin level at } V_{CC} = 28 \text{ V} - \text{DRV unloaded} \qquad 6 \qquad 10 \qquad 12 \\ \textbf{CURRENT COMPARATOR} \\ I_{IB} \text{Input Bias Current @ } 0.8 \text{ V input level on pin } 4 \qquad 4 \qquad 0.02 \\ V_{Limit1} \text{Maximum internal current setpoint } -T_J = 25^{\circ}\text{C} - \text{pin 3 grounded} \qquad 4 \qquad 0.724 \qquad 0.8 \\ V_{Icmit2} \text{Maximum internal voltage set point for frequency foldback trip point } -45\% \text{ of } V_{limit} \qquad 3 \qquad 357 \\ V_{freeze} \text{Internal peak current setpoint freeze} \left(\approx 31\% \text{ of } V_{limit}\right) \qquad 3 \qquad 250 \\ T_{DEL} \text{Propagation delay from current detection to gate off-state} \qquad 4 \qquad 100 \\ T_{LEB} \text{Leading Edge Blanking Duration} \qquad 4 \qquad 300 \\ TSS \text{Internal soft-start duration activated upon startup, auto-recovery} \qquad - \qquad 4 \\ IOPPo \text{Setpoint decrease for pin 3 biased to } -250 \text{ mV} - (\text{Note } 6), T_J = 25^{\circ}\text{C}} \qquad 3 \qquad 0.51 0.55 \\ \text{IOOPV} \text{Voltage setpoint for pin 3 biased to } -250 \text{ mV} - (\text{Note } 6), T_J = 25^{\circ}\text{C}} \qquad 3 \qquad 0.51 0.55 \\ \text{INDERSON} $	ICCstby		5		550		μΑ	
DRIVE OUTPUT T_f Output voltage rise-time @ C_L = 1 nF, 10–90% of output signal 6 40 T_f Output voltage fall-time @ C_L = 1 nF, 10–90% of output signal 6 30 R_{OH} Source resistance 6 13 R_{OL} Sink resistance 6 6.0 I_{source} Peak source current, V_{GS} = 0 V – (Note 5) 6 300 I_{sink} Peak sink current, V_{GS} = 12 V – (Note 5) 6 500 V_{DRVlow} DRV pin level at V_{CC} close to $VCC_{(min)}$ with a 33 kΩ resistor to GND 6 8.0 $V_{DRVloyhigh}$ DRV pin level at V_{CC} close to $VCC_{(min)}$ with a 33 kΩ resistor to GND 6 8.0 $V_{DRVhigh}$ DRV pin level at V_{CC} close to $VCC_{(min)}$ with a 33 kΩ resistor to GND 6 8.0 $V_{DRVhigh}$ DRV pin level at V_{CC} close to $VCC_{(min)}$ with a 33 kΩ resistor to GND 6 8.0 $V_{DRVhigh}$ DRV pin level at V_{CC} close to $VCC_{(min)}$ with a 33 kΩ resistor to GND 6 8.0 $V_{DRVhigh}$ DRV pin level at V_{CC} close to $VCC_{(min)}$ with a 33 kΩ resistor to GND 6 9 0 $V_{DRVhigh}$ DRV pin level at V_{CC} cl	ICC _{LATCH}	$T_{J} = -40^{\circ}\text{C to } +125^{\circ}\text{C}$	5				μΑ	
$ \begin{array}{cccccccccccccccccccccccccccccccccccc$	R _{lim}	Current-limit resistor in series with the latch SCR	5		4.0		kΩ	
$ \begin{array}{c} T_f & \text{Output voltage fall-time @ C_L = 1 nF, 10-90\% of output signal} & 6 & 30 \\ R_{OH} & \text{Source resistance} & 6 & 13 \\ R_{OL} & \text{Sink resistance} & 6 & 6.0 \\ I_{\text{source}} & \text{Peak source current, V}_{\text{GS}} = 0 \text{ V} - (\text{Note 5}) & 6 & 300 \\ I_{\text{sink}} & \text{Peak sink current, V}_{\text{GS}} = 12 \text{ V} - (\text{Note 5}) & 6 & 500 \\ V_{DRVlow} & \text{DRV pin level at V}_{\text{CC}} \text{ close to VCC}_{\text{(min)}} \text{ with a 33 k}\Omega \text{ resistor to GND} & 6 & 8.0 \\ V_{DRVhigh} & \text{DRV pin level at V}_{\text{CC}} = 28 \text{ V} - \text{DRV unloaded} & 6 & 10 & 12 \\ \hline \textbf{CURRENT COMPARATOR} & 4 & 0.02 \\ V_{\text{Limit1}} & \text{Maximum internal current setpoint - T}_{\text{J}} = 25^{\circ}\text{C} - \text{pin 3 grounded} & 4 & 0.744 & 0.8 \\ \hline V_{\text{Ionit2}} & \text{Maximum internal current setpoint - T}_{\text{J}} = -40^{\circ}\text{C to 125}^{\circ}\text{C} - \text{pin 3 grounded} & 4 & 0.72 & 0.8 \\ \hline V_{\text{fold}} & \text{Default internal voltage set point for frequency foldback trip point - 45% of V}_{\text{limit}} & 3 & 357 \\ \hline V_{\text{freeze}} & \text{Internal peak current setpoint freeze} (~31\% \text{ of V}_{\text{limit}}) & 3 & 250 \\ \hline T_{\text{DEL}} & \text{Propagation delay from current detection to gate off-state} & 4 & 100 \\ \hline T_{\text{LEB}} & \text{Leading Edge Blanking Duration} & 4 & 300 \\ \hline TSS & \text{Internal soft-start duration activated upon startup, auto-recovery} & - & 4 \\ \hline \text{IOPPo} & \text{Setpoint decrease for pin 3 biased to -250 mV} - (\text{Note 6}), T_{\text{J}} = 25^{\circ}\text{C} & 3 & 0.51 & 0.55 \\ \hline \end{array}$	DRIVE OUT	PUT						
R_{OH} Source resistance613 R_{OL} Sink resistance66.0 I_{source} Peak source current, $V_{GS} = 0 \text{ V} - (\text{Note 5})$ 6300 I_{sink} Peak sink current, $V_{GS} = 12 \text{ V} - (\text{Note 5})$ 6500 V_{DRVlow} DRV pin level at V_{CC} close to $VCC_{(min)}$ with a 33 kΩ resistor to GND68.0 $V_{DRVhigh}$ DRV pin level at $V_{CC} = 28 \text{ V} - DRV$ unloaded61012CURRENT COMPARATOR I_{IB} Input Bias Current @ 0.8 V input level on pin 440.02 V_{Limit1} Maximum internal current setpoint $-T_J = 25^{\circ}C - \text{pin 3 grounded}$ 40.7440.8 V_{Limit2} Maximum internal current setpoint $-T_J = -40^{\circ}C$ to $125^{\circ}C - \text{pin 3 grounded}$ 40.720.8 V_{fold} Default internal voltage set point for frequency foldback trip point -45% of V_{limit} 3357 V_{freeze} Internal peak current setpoint freeze ($\approx 31\%$ of V_{limit})3250 T_{DEL} Propagation delay from current detection to gate off-state4100 T_{LEB} Leading Edge Blanking Duration4300TSSInternal soft-start duration activated upon startup, auto-recovery-4IOPPoSetpoint decrease for pin 3 biased to $-250 \text{ mV} - (\text{Note 6})$ 30.510.55	T _r	Output voltage rise-time @ C _L = 1 nF, 10-90% of output signal	6		40		ns	
R_{OL} Sink resistance66.0 I_{source} Peak source current, $V_{GS} = 0 \text{ V} - (\text{Note 5})$ 6300 I_{sink} Peak sink current, $V_{GS} = 12 \text{ V} - (\text{Note 5})$ 6500 V_{DRVlow} DRV pin level at V_{CC} close to $VCC_{(min)}$ with a 33 kΩ resistor to GND68.0 $V_{DRVhigh}$ DRV pin level at $V_{CC} = 28 \text{ V} - DRV$ unloaded61012CURRENT COMPARATOR I_{IB} Input Bias Current @ 0.8 V input level on pin 440.02 V_{Limit1} Maximum internal current setpoint $-T_J = 25^{\circ}C - \text{pin 3 grounded}$ 40.7440.8 V_{Limit2} Maximum internal current setpoint $-T_J = -40^{\circ}C$ to $125^{\circ}C - \text{pin 3 grounded}$ 40.720.8 V_{fold} Default internal voltage set point for frequency foldback trip point -45% of V_{limit} 3357 V_{freeze} Internal peak current setpoint freeze ($\approx 31\%$ of V_{limit})3250 T_{DEL} Propagation delay from current detection to gate off-state4100 T_{LEB} Leading Edge Blanking Duration4300TSSInternal soft-start duration activated upon startup, auto-recovery-4IOPPoSetpoint decrease for pin 3 biased to $-250 \text{ mV} - (\text{Note 6})$, $T_J = 25^{\circ}C$ 30.510.55	T _f	Output voltage fall-time @ C _L = 1 nF, 10-90% of output signal	6		30		ns	
Sc.IsourcePeak source current, $V_{GS} = 0 \text{ V} - (\text{Note 5})$ 6300 I_{sink} Peak sink current, $V_{GS} = 12 \text{ V} - (\text{Note 5})$ 6500 V_{DRVlow} DRV pin level at V_{CC} close to VCC(min) with a 33 kΩ resistor to GND68.0 V_{DRVhigh} DRV pin level at $V_{\text{CC}} = 28 \text{ V} - \text{DRV}$ unloaded61012CURRENT COMPARATOR I_{IB} Input Bias Current @ 0.8 V input level on pin 440.02 V_{Limit1} Maximum internal current setpoint $-T_J = 25^{\circ}\text{C} - \text{pin 3 grounded}$ 40.7440.8 V_{Limit2} Maximum internal current setpoint $-T_J = -40^{\circ}\text{C}$ to $125^{\circ}\text{C} - \text{pin 3 grounded}$ 40.720.8 V_{fold} Default internal voltage set point for frequency foldback trip point -45% of V_{limit} 3357 V_{freeze} Internal peak current setpoint freeze (≈31% of V_{limit})3250 T_{DEL} Propagation delay from current detection to gate off-state4100 T_{LEB} Leading Edge Blanking Duration4300TSSInternal soft-start duration activated upon startup, auto-recovery-4IOPPoSetpoint decrease for pin 3 biased to $-250 \text{ mV} - (\text{Note 6})$, $T_J = 25^{\circ}\text{C}$ 30.510.55	R _{OH}	Source resistance	6		13		Ω	
I_{sink} Peak sink current, $V_{GS} = 12 \text{ V} - (\text{Note 5})$ 6500 V_{DRVlow} DRV pin level at V_{CC} close to $VCC_{(min)}$ with a 33 kΩ resistor to GND68.0 $V_{DRVhigh}$ DRV pin level at $V_{CC} = 28 \text{ V} - DRV$ unloaded61012CURRENT COMPARATOR I_{IB} Input Bias Current @ 0.8 V input level on pin 440.02 V_{Limit1} Maximum internal current setpoint $-T_J = 25^{\circ}C - \text{pin 3 grounded}$ 40.7440.8 V_{Limit2} Maximum internal current setpoint $-T_J = -40^{\circ}C$ to $125^{\circ}C - \text{pin 3 grounded}$ 40.720.8 V_{fold} Default internal voltage set point for frequency foldback trip point -45% of V_{limit} 3357 V_{freeze} Internal peak current setpoint freeze ($\approx 31\%$ of V_{limit})3250 T_{DEL} Propagation delay from current detection to gate off-state4100 T_{LEB} Leading Edge Blanking Duration4300TSSInternal soft-start duration activated upon startup, auto-recovery-4IOPPoSetpoint decrease for pin 3 biased to $-250 \text{ mV} - (\text{Note 6})$ 331.3IOOPVVoltage setpoint for pin 3 biased to $-250 \text{ mV} - (\text{Note 6})$, $T_J = 25^{\circ}C$ 30.510.55	R _{OL}	Sink resistance	6		6.0		Ω	
V_{DRVlow} DRV pin level at V_{CC} close to $VCC_{(min)}$ with a 33 kΩ resistor to GND68.0 $V_{DRVhigh}$ DRV pin level at $V_{CC} = 28 \text{ V} - DRV$ unloaded61012CURRENT COMPARATOR I_{IB} Input Bias Current @ 0.8 V input level on pin 440.02 V_{Limit1} Maximum internal current setpoint $-T_J = 25^{\circ}C - \text{pin 3 grounded}$ 40.7440.8 V_{Limit2} Maximum internal current setpoint $-T_J = -40^{\circ}C$ to $125^{\circ}C - \text{pin 3 grounded}$ 40.720.8 V_{fold} Default internal voltage set point for frequency foldback trip point -45% of V_{limit} 3357 V_{freeze} Internal peak current setpoint freeze ($\approx 31\%$ of V_{limit})3250 T_{DEL} Propagation delay from current detection to gate off-state4100 T_{LEB} Leading Edge Blanking Duration4300TSSInternal soft-start duration activated upon startup, auto-recovery-4IOPPoSetpoint decrease for pin 3 biased to $-250 \text{ mV} - (\text{Note 6})$ 331.3IOOPvVoltage setpoint for pin 3 biased to $-250 \text{ mV} - (\text{Note 6})$, $T_J = 25^{\circ}C$ 30.510.55	I _{source}	Peak source current, V _{GS} = 0 V – (Note 5)	6		300		mA	
VDRVhighDRV pin level at VCC = 28 V − DRV unloaded61012CURRENT COMPARATOR I_{IB} Input Bias Current @ 0.8 V input level on pin 440.02 V_{Limit1} Maximum internal current setpoint $-T_J = 25^{\circ}\text{C} - \text{pin 3 grounded}$ 40.7440.8 V_{Limit2} Maximum internal current setpoint $-T_J = -40^{\circ}\text{C}$ to $125^{\circ}\text{C} - \text{pin 3 grounded}$ 40.720.8 V_{fold} Default internal voltage set point for frequency foldback trip point -45% of V_{limit} 3357 V_{freeze} Internal peak current setpoint freeze ($\approx 31\%$ of V_{limit})3250 T_{DEL} Propagation delay from current detection to gate off-state4100 T_{LEB} Leading Edge Blanking Duration4300TSSInternal soft-start duration activated upon startup, auto-recovery-4IOPPoSetpoint decrease for pin 3 biased to $-250 \text{ mV} - (\text{Note 6})$ 331.3IOOPVVoltage setpoint for pin 3 biased to $-250 \text{ mV} - (\text{Note 6})$, $T_J = 25^{\circ}\text{C}$ 30.510.55	I _{sink}	Peak sink current, V _{GS} = 12 V – (Note 5)	6		500		mA	
CURRENT COMPARATOR I_{IB} Input Bias Current @ 0.8 V input level on pin 440.02 V_{Limit1} Maximum internal current setpoint $-T_J = 25^{\circ}\text{C} - \text{pin 3 grounded}$ 40.7440.8 V_{Limit2} Maximum internal current setpoint $-T_J = -40^{\circ}\text{C}$ to $125^{\circ}\text{C} - \text{pin 3 grounded}$ 40.720.8 V_{fold} Default internal voltage set point for frequency foldback trip point -45% of V_{limit} 3357 V_{freeze} Internal peak current setpoint freeze ($\approx 31\%$ of V_{limit})3250 T_{DEL} Propagation delay from current detection to gate off-state4100 T_{LEB} Leading Edge Blanking Duration4300TSSInternal soft-start duration activated upon startup, auto-recovery-4IOPPoSetpoint decrease for pin 3 biased to $-250 \text{ mV} - (\text{Note 6})$ 331.3IOOPvVoltage setpoint for pin 3 biased to $-250 \text{ mV} - (\text{Note 6})$, $T_J = 25^{\circ}\text{C}$ 30.510.55	V_{DRVlow}	DRV pin level at V_{CC} close to $VCC_{(min)}$ with a 33 k Ω resistor to GND	6	8.0			V	
I_{IB} Input Bias Current @ 0.8 V input level on pin 440.02 V_{Limit1} Maximum internal current setpoint $-T_J = 25^{\circ}\text{C} - \text{pin 3 grounded}$ 40.7440.8 V_{Limit2} Maximum internal current setpoint $-T_J = -40^{\circ}\text{C}$ to $125^{\circ}\text{C} - \text{pin 3 grounded}$ 40.720.8 V_{fold} Default internal voltage set point for frequency foldback trip point -45% of V_{limit} 3357 V_{freeze} Internal peak current setpoint freeze ($\approx 31\%$ of V_{limit})3250 T_{DEL} Propagation delay from current detection to gate off-state4100 T_{LEB} Leading Edge Blanking Duration4300TSSInternal soft-start duration activated upon startup, auto-recovery-4IOPPoSetpoint decrease for pin 3 biased to $-250 \text{ mV} - (\text{Note 6})$ 331.3IOOPvVoltage setpoint for pin 3 biased to $-250 \text{ mV} - (\text{Note 6})$, $T_J = 25^{\circ}\text{C}$ 30.510.55	$V_{DRVhigh}$	DRV pin level at V _{CC} = 28 V – DRV unloaded	6	10	12	14	V	
V_{Limit1} Maximum internal current setpoint $-T_J = 25^{\circ}\text{C} - \text{pin 3 grounded}$ 4 0.744 0.8 V_{Limit2} Maximum internal current setpoint $-T_J = -40^{\circ}\text{C}$ to $125^{\circ}\text{C} - \text{pin 3 grounded}$ 4 0.72 0.8 V_{fold} Default internal voltage set point for frequency foldback trip point -45% of V_{limit} 3 357 V_{freeze} Internal peak current setpoint freeze ($\approx 31\%$ of V_{limit})3 250 T_{DEL} Propagation delay from current detection to gate off-state4 100 T_{LEB} Leading Edge Blanking Duration4 300 TSSInternal soft-start duration activated upon startup, auto-recovery- 4 IOPPoSetpoint decrease for pin 3 biased to $-250 \text{ mV} - (\text{Note 6})$ 3 31.3 IOOPvVoltage setpoint for pin 3 biased to $-250 \text{ mV} - (\text{Note 6})$, $T_J = 25^{\circ}\text{C}$ 3 0.51 0.55	CURRENT C	COMPARATOR						
V_{Limit2} Maximum internal current setpoint $-T_J = -40^{\circ}\text{C}$ to $125^{\circ}\text{C} - \text{pin 3 grounded}$ 40.720.8 V_{fold} Default internal voltage set point for frequency foldback trip point -45% of V_{limit} 3357 V_{freeze} Internal peak current setpoint freeze ($\approx 31\%$ of V_{limit})3250 T_{DEL} Propagation delay from current detection to gate off-state4100 T_{LEB} Leading Edge Blanking Duration4300TSSInternal soft-start duration activated upon startup, auto-recovery-4IOPPoSetpoint decrease for pin 3 biased to $-250 \text{ mV} - (\text{Note 6})$ 331.3IOOPvVoltage setpoint for pin 3 biased to $-250 \text{ mV} - (\text{Note 6})$, $T_J = 25^{\circ}\text{C}$ 30.510.55	I _{IB}	Input Bias Current @ 0.8 V input level on pin 4	4		0.02		μΑ	
Vfold Default internal voltage set point for frequency foldback trip point − 45% of V_{limit} 3 357 Vfreeze Internal peak current setpoint freeze (≈31% of V_{limit}) 3 250 TDEL Propagation delay from current detection to gate off–state 4 100 TLEB Leading Edge Blanking Duration 4 300 TSS Internal soft–start duration activated upon startup, auto–recovery − 4 IOPPo Setpoint decrease for pin 3 biased to −250 mV − (Note 6) 3 31.3 IOOPv Voltage setpoint for pin 3 biased to −250 mV − (Note 6), TJ = 25°C 3 0.51 0.55	V _{Limit1}	Maximum internal current setpoint – T _J = 25°C – pin 3 grounded	4	0.744	0.8	0.856	V	
V _{freeze} Internal peak current setpoint freeze (≈31% of V_{limit}) 3 250 T _{DEL} Propagation delay from current detection to gate off–state 4 100 T _{LEB} Leading Edge Blanking Duration 4 300 TSS Internal soft–start duration activated upon startup, auto–recovery − 4 IOPPo Setpoint decrease for pin 3 biased to −250 mV − (Note 6) 3 31.3 IOOPv Voltage setpoint for pin 3 biased to −250 mV − (Note 6), T _J = 25°C 3 0.51 0.55	V _{Limit2}	Maximum internal current setpoint – T _J = -40°C to 125°C – pin 3 grounded	4	0.72	0.8	0.88	V	
T_{DEL} Propagation delay from current detection to gate off-state 4 100 T_{LEB} Leading Edge Blanking Duration 4 300 TSS Internal soft-start duration activated upon startup, auto-recovery - 4 IOPPo Setpoint decrease for pin 3 biased to -250 mV - (Note 6) 3 31.3 IOOPv Voltage setpoint for pin 3 biased to -250 mV - (Note 6), $T_J = 25^{\circ}C$ 3 0.51 0.55	V_{fold}	Default internal voltage set point for frequency foldback trip point – 45% of V _{limit}	3		357		mV	
TLEB Leading Edge Blanking Duration 4 300 TSS Internal soft-start duration activated upon startup, auto-recovery - 4 IOPPo Setpoint decrease for pin 3 biased to -250 mV - (Note 6) 3 31.3 IOOPv Voltage setpoint for pin 3 biased to -250 mV - (Note 6), TJ = 25°C 3 0.51 0.55	V_{freeze}	Internal peak current setpoint freeze (≈31% of V _{limit})	3		250		mV	
TSS Internal soft–start duration activated upon startup, auto–recovery – 4 IOPPo Setpoint decrease for pin 3 biased to –250 mV – (Note 6) 3 31.3 IOOPv Voltage setpoint for pin 3 biased to –250 mV – (Note 6), T _J = 25°C 3 0.51 0.55	T _{DEL}	Propagation delay from current detection to gate off-state	4		100	150	ns	
IOPPoSetpoint decrease for pin 3 biased to -250 mV - (Note 6)331.3IOOPvVoltage setpoint for pin 3 biased to -250 mV - (Note 6), T _J = 25°C30.510.55	T _{LEB}	Leading Edge Blanking Duration	4		300		ns	
IOOPv Voltage setpoint for pin 3 biased to –250 mV – (Note 6), T _J = 25°C 3 0.51 0.55	TSS	Internal soft-start duration activated upon startup, auto-recovery	_		4		ms	
	IOPPo	Setpoint decrease for pin 3 biased to -250 mV - (Note 6)	3		31.3		%	
	IOOPv	Voltage setpoint for pin 3 biased to −250 mV − (Note 6), T _J = 25°C	3	0.51	0.55	0.60	V	
IOOPv Voltage setpoint for pin 3 biased to $-250 \text{ mV} - (\text{Note 6})$, $T_J = -40^{\circ}\text{C}$ to 125°C 3 0.50 0.55	IOOPv	Voltage setpoint for pin 3 biased to -250 mV - (Note 6), T _J = -40°C to 125°C	3	0.50	0.55	0.62	V	
IOPPs Setpoint decrease for pin 3 grounded 3 0	IOPPs	Setpoint decrease for pin 3 grounded	3		0		%	

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

- 4. For design robustness, we recommend to inject 60 μA as a minimum at the lowest input line voltage.
- 5. Guaranteed by design6. See characterization table for linearity over negative bias voltage
- 7. A 1 $\mbox{M}\Omega$ resistor is connected from pin 3 to the ground for the measurement.

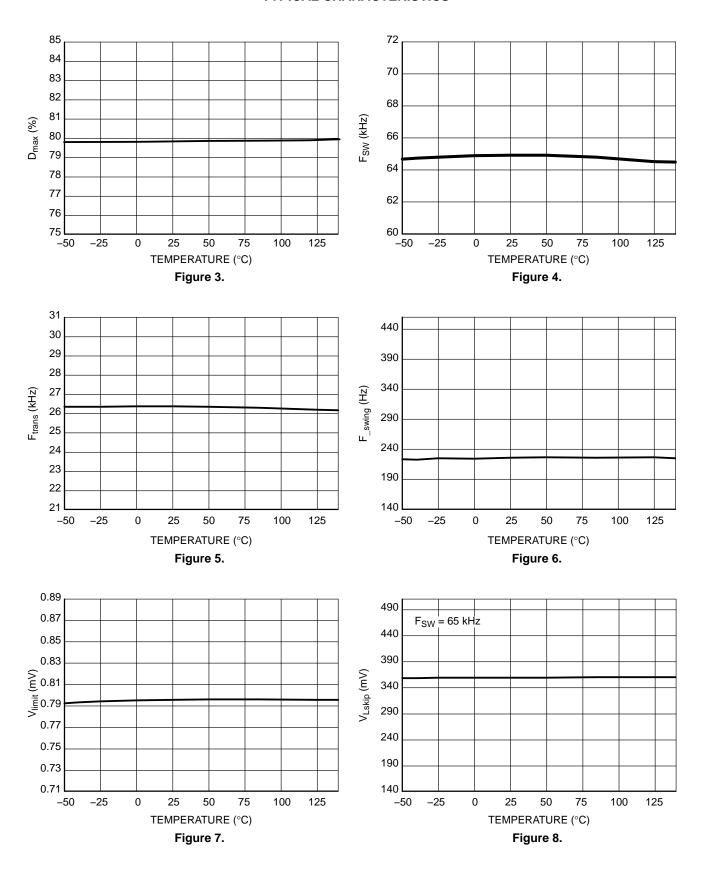
ELECTRICAL CHARACTERISTICS

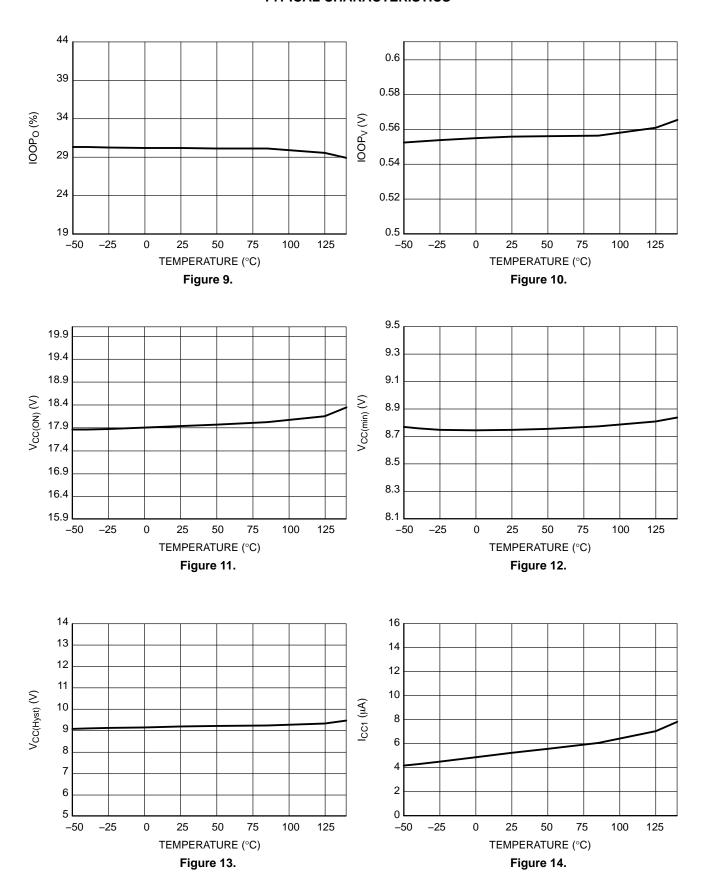
(For typical values $T_J = 25^{\circ}C$, for min/max values $T_J = -40^{\circ}C$ to $+125^{\circ}C$, Max $T_J = 150^{\circ}C$, $V_{CC} = 12$ V unless otherwise noted)

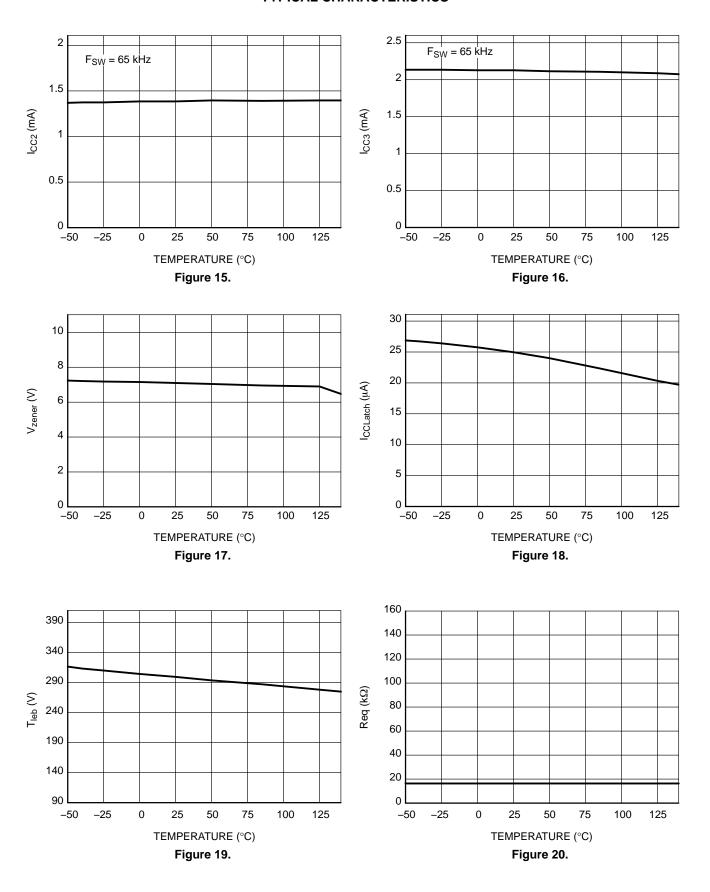
Symbol	Rating	Pin	Min	Тур	Max	Unit	
INTERNAL OSCILLATOR							
fosc	Oscillation frequency (65 kHz version)	-	61	65	71	kHz	
f _{OSC}	Oscillation frequency (100 kHz version)	-	92	100	108	kHz	
D _{max}	Maximum duty-cycle	-	76	80	84	%	
f _{jitter}	Frequency jittering in percentage of f _{OSC}	-		±5		%	
f _{swing}	Swing frequency	-		240		Hz	
FEEDBACK	SECTION						
R_{up}	Internal pull-up resistor	2		20		kΩ	
R _{eq}	Equivalent ac resistor from FB to GND	2		16		kΩ	
I _{ratio}	Pin 2 to current setpoint division ratio	_		4.2			
V _{freeze}	Feedback voltage below which the peak current is frozen	2		1.05		V	
FREQUENC	Y FOLDBACK						
V_{fold}	Frequency foldback level on the feedback pin – \approx 45% of maximum peak current	-		1.5		V	
V _{foldF}	Frequency foldback level on the feedback pin – $\approx\!59\%$ of maximum peak current (F version only)	-		1.9		V	
F _{trans}	Transition frequency below which skip-cycle occurs	-	22	26	30	kHz	
V _{fold,end}	End of frequency foldback feedback level, F _{sw} = F _{min}			350		mV	
V _{foldF,end}	End of frequency foldback feedback level, F _{sw} = F _{min} (F version only)			1.5		V	
V_{skip}	Skip-cycle level voltage on the feedback pin	-		300		mV	
Skip hysteresis	Hysteresis on the skip comparator – (Note 5)	-		30		mV	
INTERNAL	SLOPE COMPENSATION	-					
V_{ramp}	Internal ramp level @ 25°C – (Note 7)	4		2.5		V	
R _{ramp}	Internal ramp resistance to CS pin	4		20		kΩ	
PROTECTIO	ons						
V_{latch}	Latching level input	3	2.7	3	3.3	V	
T _{latch-blank}	Blanking time after drive turn off	1		1.0		μS	
T _{latch-count}	Number of clock cycles before latch confirmation	-		4.0			
T _{latch-del}	OVP detection time constant	1		600		ns	
Timer	Internal auto-recovery fault timer duration	-	100	130	160	ms	
V _{OVP}	Latched Over voltage protection on the V _{CC} rail	5	24	25.5	27	V	
T _{OVPdel}	Delay before OVP on V _{CC} confirmation	5		20		μS	

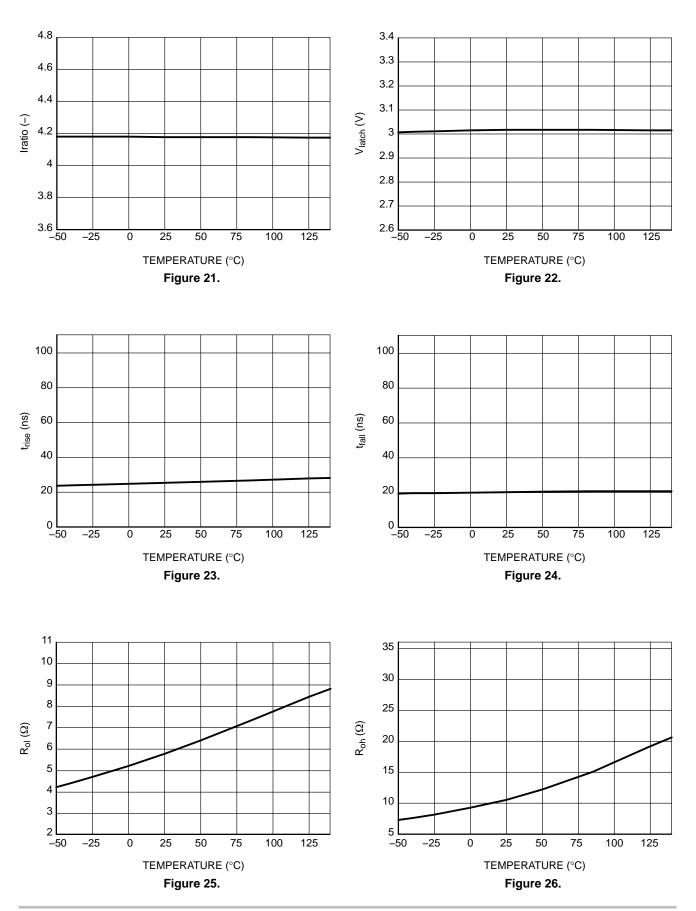
Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

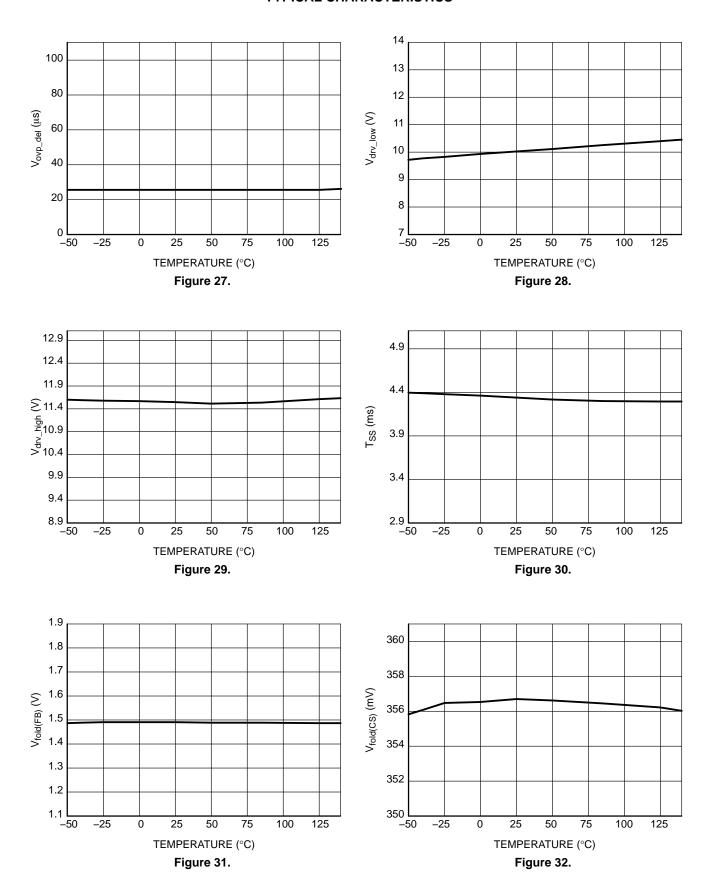
- 4. For design robustness, we recommend to inject $60~\mu\text{A}$ as a minimum at the lowest input line voltage. 5. Guaranteed by design 6. See characterization table for linearity over negative bias voltage 7. A 1 M Ω resistor is connected from pin 3 to the ground for the measurement.

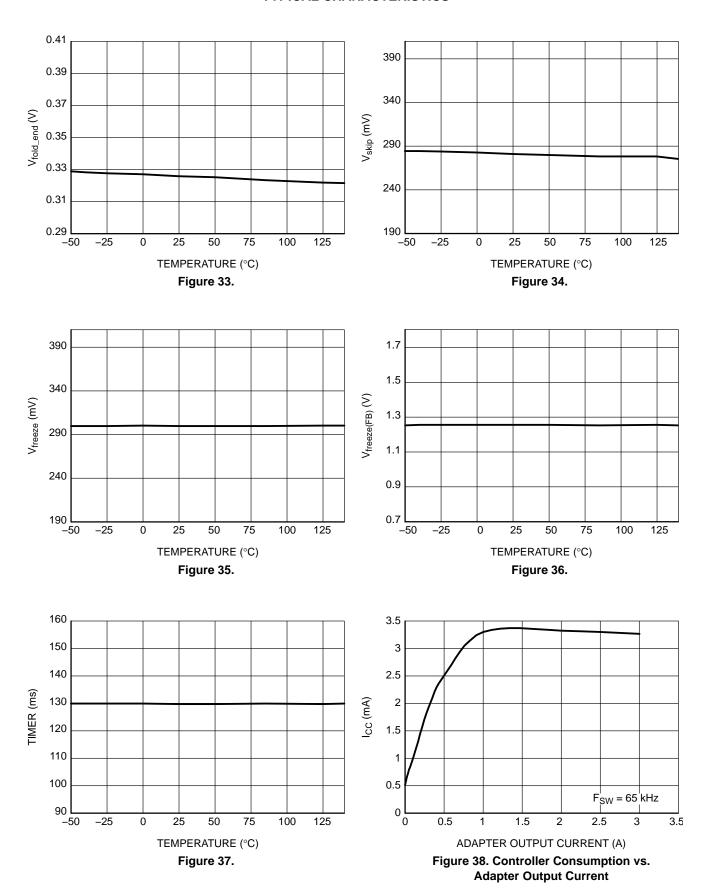












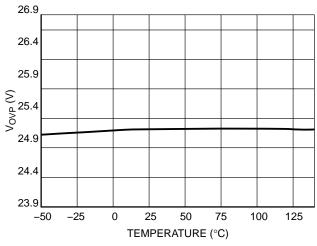


Figure 39.

APPLICATION INFORMATION

Introduction

The NCP1251 implements a standard current mode architecture where the switch-off event is dictated by the peak current setpoint. This component represents the ideal candidate where low part-count and cost effectiveness are the key parameters, particularly in low-cost ac-dc adapters, open-frame power supplies etc. Capitalizing on the NCP120X series success, the NCP1251 packs all the necessary components normally needed in today modern power supply designs, bringing several enhancements such as a non-dissipative OPP.

- Current-mode operation with internal ramp compensation: Implementing peak current mode control at a fixed 65 kHz or 100 kHz, the NCP1251 offers an internal ramp compensation signal that can easily by summed with the sensed current. Sub harmonic oscillations are eliminated via the inclusion of a single resistor in series with the current-sense information.
- Internal OPP: By routing a portion of the negative voltage present during the on–time on the auxiliary winding to the dedicated OPP pin (pin 3), the user has a simple and non–dissipative means to alter the maximum peak current setpoint as the bulk voltage increases. If the pin is grounded, no OPP compensation occurs. If the pin receives a negative voltage down to –250 mV, then a peak current reduction down to 31.3% typical can be achieved. For an improved performance, the maximum voltage excursion on the sense resistor is limited to 0.8 V.
- Low startup current: Achieving a low no-load standby power always represents a difficult exercise when the controller draws a significant amount of current during start-up. Due to its proprietary architecture, the NCP1251 is guaranteed to draw less than 15 µA typical, easing the design of low standby power adapters.
- EMI jittering: An internal low–frequency modulation signal varies the pace at which the oscillator frequency is modulated. This helps by spreading out energy in conducted noise analysis. To improve the EMI signature at low power levels, the jittering remains active in frequency foldback mode.
- Frequency foldback capability: A continuous flow of pulses is not compatible with no-load/light-load standby power requirements. To excel in this domain, the controller observes the feedback pin and when it reaches a level of 1.5 V, the oscillator then starts to reduce its switching frequency as the feedback level continues to decrease. When the feedback pin reaches 1.05 V, the peak current setpoint is internally frozen and the frequency continues to decrease. It can go down to

- 26 kHz (typical) reached for a feedback level of roughly 350 mV. At this point, if the power continues to drop, the controller enters classical skip—cycle mode.
- Internal soft-start: A soft-start precludes the main power switch from being stressed upon start-up. In this controller, the soft-start is internally fixed to 4 ms. The soft-start is activated when a new startup sequence occurs or during an auto-recovery hiccup.
- **OVP input**: The NCP1251 includes a latch input (pin 3) that can be used to sense an overvoltage condition on the adapter. If this pin is brought higher than the internal reference voltage V_{latch}, then the circuit permanently latches off. The V_{CC} pin is pulled down to a fixed level, keeping the controller latched. The latch reset occurs when the user disconnects the adapter from the mains and lets the V_{CC} falls below the V_{CC} reset.
- Latched OVP on V_{CC}: It is sometimes interesting to implement a circuit protection by sensing the V_{CC} level. This is what the NCP1251 does by monitoring its V_{CC} pin. When the voltage on this pin exceeds 25 V typical, the pulses are immediately stopped and the part latches off. The Vcc is maintained to 7 V typical and remains in this state until the user unplugs the power supply.
- Short-circuit protection: Short-circuit and especially over-load protections are difficult to implement for transformers with high leakage inductance between auxiliary and power windings (the aux winding level does not properly collapse in presence of an output short). Here, every time the internal 0.8 V maximum peak current limit is activated (or less when OPP is used), an error flag is asserted and a time period starts, thanks to an internal timer. If the timer reaches completion while the error flag is still present, the controller stops the pulses and goes into a latch-off phase, operating in a low-frequency burst-mode. When the fault is cleared, the SMPS resumes operation. Please note that some versions offer an auto-recovery mode as described and some latch off in case of a short circuit.

Start-up Sequence

The NCP1251 start—up voltage is made purposely high to permit a large energy storage in a small V_{CC} capacitor value. This helps to operate with a small start—up current which, together with a small V_{CC} capacitor, will not hamper the start—up time. To further reduce the standby power, the start—up current of the controller is extremely low, below 15 μ A maximum. The start—up resistor can therefore be connected to the bulk capacitor or directly to the mains input voltage to further reduce the power dissipation.

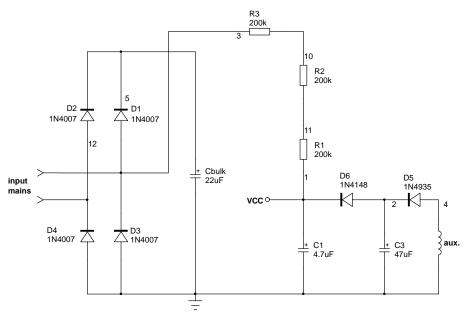


Figure 40. The Startup Resistor Can Be Connected to the Input Mains for Further Power Dissipation Reduction

The first step starts with the calculation of the V_{CC} capacitor which will supply the controller when it operates until the auxiliary winding takes over. Experience shows that this time t_1 can be between 5 ms and 20 ms. If we consider we need at least an energy reservoir for a t_1 time of 10 ms, the V_{CC} capacitor must be larger than:

$$CV_{CC} \geq \frac{I_{CC}t_1}{VCC_{on} - VCC_{min}} \geq \frac{3m \times 10m}{9} \geq 3.3 \ \mu F \tag{eq. 1}$$

Let us select a 4.7 μ F capacitor at first and experiments in the laboratory will let us know if we were too optimistic for the time t_1 . The V_{CC} capacitor being known, we can now evaluate the charging current we need to bring the V_{CC} voltage from 0 to the VCC_{on} of the IC, 18 V typical. This current has to be selected to ensure a start—up at the lowest mains (85 V rms) to be less than 3 s (2.5 s for design margin):

$$I_{charge} \geq \frac{VCC_{on}C_{VCC}}{2.5} \geq \frac{18 \times 4.7 \mu}{2.5} \geq 34 \,\mu\text{A} \tag{eq. 2}$$

If we account for the 15 μA that will flow inside the controller, then the total charging current delivered by the start-up resistor must be 49 μA . If we connect the start-up network to the mains (half-wave connection then), we know that the average current flowing into this start-up resistor will be the smallest when V_{CC} reaches the VCC_{on} of the controller:

$$I_{\text{CVCC,min}} = \frac{\frac{V_{\text{ac,rms}}\sqrt{2}}{\pi} - \text{VCC}_{\text{on}}}{R_{\text{start-up}}}$$
 (eq. 3)

To make sure this current is always greater than 49 μ A, then the minimum value for $R_{start-up}$ can be extracted:

$$R_{start-up} \leq \frac{\frac{^{V}ac, rms^{\sqrt{2}}}{\pi} - VCC_{on}}{I_{CVCC, min}} \leq \frac{\frac{85 \times 1.414}{\pi} - 18}{49 \mu} \leq \frac{413.5 \text{ k}\Omega}{(eq.\ 4)}$$

This calculation is purely theoretical, and assumes a constant charging current. In reality, the take over time can be shorter (or longer!) and it can lead to a reduction of the V_{CC} capacitor. Hence, a decrease in charging current and an increase of the start–up resistor, thus reducing the standby power. Laboratory experiments on the prototype are thus mandatory to fine tune the converter. If we chose the 413 k Ω resistor as suggested by Equation 4, the dissipated power at high line amounts to:

$$P_{Rstart-up} = \frac{V_{ac,peak}^{2}}{4R_{start-up}} = \frac{(230 \times \sqrt{2})^{2}}{4 \times 413k}$$

$$= \frac{230^{2}}{0.827Meg} = 64 \text{ mW}$$
(eq. 5)

Now that the first V_{CC} capacitor has been selected, we must ensure that the self-supply does not disappear when in no-load conditions. In this mode, the skip-cycle can be so deep that refreshing pulses are likely to be widely spaced, inducing a large ripple on the V_{CC} capacitor. If this ripple is too large, chances exist to touch the VCC_{min} and reset the controller into a new start-up sequence. A solution is to grow this capacitor but it will obviously be detrimental to the start-up time. The option offered in Figure 40 elegantly solves this potential issue by adding an extra capacitor on the auxiliary winding. However, this component is separated from the V_{CC} pin via a simple diode. You therefore have the ability to grow this capacitor as you need to ensure the self-supply of the controller without jeopardizing the start-up time and standby power. A capacitor ranging from 22 to 47 µF is the typical value for this device.

One note on the start-up current. If reducing it helps to improve the standby power, its value cannot fall below a certain level at the minimum input voltage. Failure to inject enough current (30 μ A) at low line will turn a converter in fault into an auto-recovery mode since the SCR won't remain latched. To build a sufficient design margin, we recommend to keep at least 60 μ A flowing at the lowest input line (80 V rms for 85 V minimum for instance). An excellent solution is to actually combine X2 discharge and start-up networks as proposed in Figure 13 of application note AND8488/D.

Internal Over Power Protection

There are several known ways to implement Over Power Protection (OPP), all suffering from particular problems. These problems range from the added consumption burden on the converter or the skip—cycle disturbance brought by

the current–sense offset. A way to reduce the power capability at high line is to capitalize on the negative voltage swing present on the auxiliary diode anode. During the power switch on–time, this point dips to –NV_{in}, *N* being the turns ratio between the primary winding and the auxiliary winding. The negative plateau observed on Figure 42 will have an amplitude dependant on the input voltage. The idea implemented in this chip is to sum a portion of this negative swing with the 0.8 V internal reference level. For instance, if the voltage swings down to –150 mV during the on time, then the internal peak current set point will be fixed to 0.8 – 0.150 = 650 mV. The adopted principle appears in Figure 42 and shows how the final peak current set point is constructed.

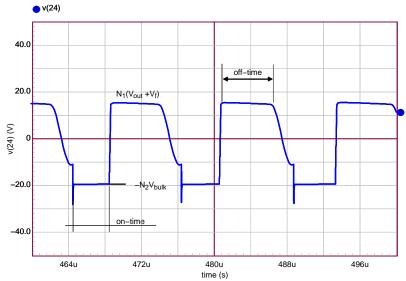


Figure 41. The Signal Obtained on the Auxiliary Winding Swings Negative During the On-time

Let's assume we need to reduce the peak current from 2.5 A at low line, to 2 A at high line. This corresponds to a 20% reduction or a set point voltage of 640 mV. To reach this

level, then the negative voltage developed on the OPP pin must reach:

$$V_{OPP} = 640m - 800m = -160 \text{ mV}$$
 (eq. 6)

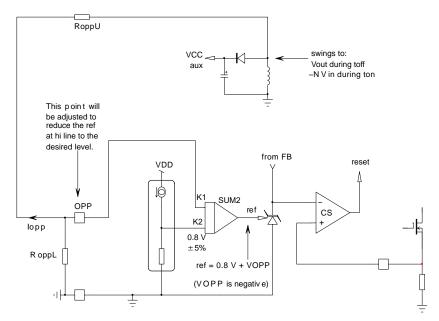


Figure 42. The OPP Circuitry Affects the Maximum Peak Current Set Point by Summing a Negative Voltage to the Internal Voltage Reference

Let us assume that we have the following converter characteristics:

$$\begin{aligned} &V_{out} = 19 \ V \\ &V_{in} = 85 \ to \ 265 \ V_{rms} \\ &N_1 = N_p; N_s = 1; 0.25 \\ &N_2 = N_p; N_{aux} = 1; 0.18 \end{aligned}$$

Given the turns ratio between the primary and the auxiliary windings, the on–time voltage at high line (265 Vac) on the auxiliary winding swings down to:

$$V_{aux} = -N_2V_{in,max} = -0.18 \times 375 = -67.5 V$$
 (eq. 7)

To obtain a level as imposed by Equation 6, we need to install a divider featuring the following ratio:

$$Div = \frac{0.16}{67.5} \approx 2.4m$$
 (eq. 8)

If we arbitrarily fix the pull–down resistor R_{OPPL} to 1 k Ω , then the upper resistor can be obtained by:

$$R_{OPPU} = \frac{67.5 - 0.16}{0.16/1k} \approx 421 \text{ k}\Omega$$
 (eq. 9)

If we now plot the peak current set point obtained by implementing the recommended resistor values, we obtain the following curve (Figure 43):

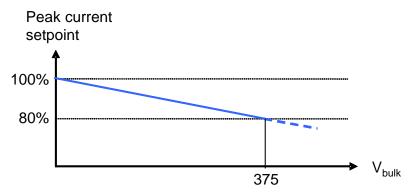


Figure 43. The Peak Current Regularly Reduces Down to 20% at 375 Vdc

The OPP pin is surrounded by Zener diodes stacked to protect the pin against ESD pulses. These diodes accept some peak current in the avalanche mode and are designed to sustain a certain amount of energy. On the other side, negative injection into these diodes (or forward bias) can cause substrate injection which can lead to an erratic circuit behavior. To avoid this problem, the pin is internally

clamped slightly below -300~mV which means that if more current is injected before reaching the ESD forward drop, then the maximum peak reduction is kept to 40%. If the voltage finally forward biases the internal zener diode, then care must be taken to avoid injecting a current beyond -2~mA. Given the value of R_{OPPU} , there is no risk in the present example.

Finally, please note that another comparator internally fixes the maximum peak current set point to 0.8 V even if the OPP pin is inadvertently biased above 0 V.

Frequency Foldback

The reduction of no–load standby power associated with the need for improving the efficiency, requires a change to the traditional fixed–frequency type of operation. This controller implements a switching frequency foldback when the feedback voltage passes below a certain level, $V_{\rm fold}$, set around 1.5 V. At this point, the oscillator enters frequency foldback and reduces its switching frequency. The peak current setpoint follows the feedback pin until its level reaches 1.05 V. Below this value, the peak current freezes to $V_{\rm fold}/4.2$ (250 mV or 31% of the maximum 0.8 V setpoint) and the only way to further reduce the transmitted power is

to reduce the operating frequency down to 26 kHz. This value is reached at a voltage feedback level of 350 mV typically. Below this point, if the output power continues to decrease, the part enters skip cycle for the best noise–free performance in no–load conditions. Figure 44 depicts the adopted scheme for the part.

The NCP1251F version offers a means to improve light–load efficiency by folding the switching frequency sooner compared to the other versions. With the 1251 A, B and C versions, the minimum frequency is reached for V_{FB} equals 350 mV. With the 1251F, this minimum frequency will be obtained at a feedback voltage equal to 1.5 V, naturally offering a better efficiency for lighter load conditions. Figure 45 portrays the specific foldback scheme implemented in the NCP1251F.

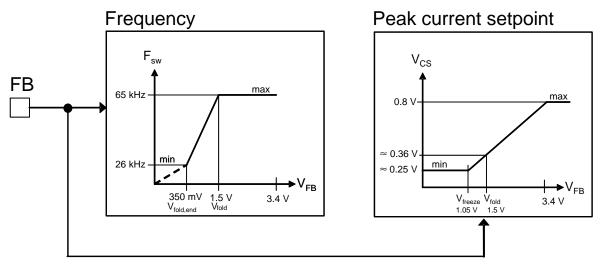


Figure 44. By Observing the Voltage on the Feedback Pin, the Controller Reduces its Switching Frequency for an Improved Performance at Light Load

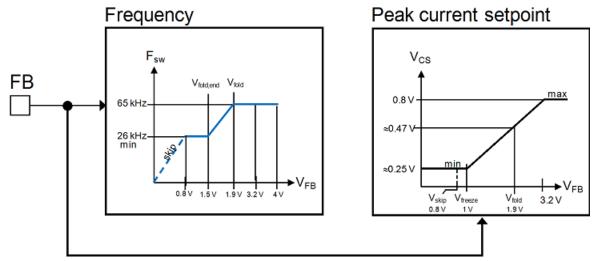


Figure 45. with NCP1251F, the frequency foldback occurs sooner as the load gets lighter.

Auto-Recovery Short-Circuit Protection

In case of output short–circuit or if the power supply experiences a severe overloading situation, an internal error flag is raised and starts a countdown timer. If the flag is asserted longer than 100 ms, the driving pulses are stopped and the V_{CC} pin slowly goes down to around 7 V. At this point, the controller wakes–up and the V_{CC} builds up again

due to the resistive starting network. When V_{CC} reaches VCC_{ON} , the controller attempts to re–start, checking for the absence of the fault. If the fault is still there, the supply enters another cycle of so–called hiccup mode. If the fault has cleared, the power supply resumes normal operation. Please note that the soft–start is activated during each of the re–start sequence.

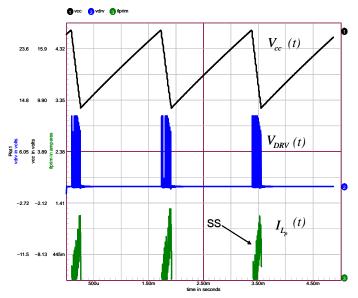


Figure 46. An Auto-Recovery Hiccup Mode is Activated for Faults Longer than 100 ms

Slope Compensation

The NCP1251 includes an internal ramp compensation signal. This is the buffered oscillator clock delivered only during the on time. Its amplitude is around 2.5 V at the maximum duty-cycle. Ramp compensation is a known means used to cure sub harmonic oscillations in Continuous Conduction Mode (CCM) operated current-mode

converters. These oscillations take place at half the switching frequency and occur only during CCM with a duty—cycle greater than 50%. To lower the current loop gain, one usually injects between 50% and 100% of the inductor downslope. Figure 47 depicts how internally the ramp is generated. Please note that the ramp signal will be disconnected from the CS pin, during the off time.

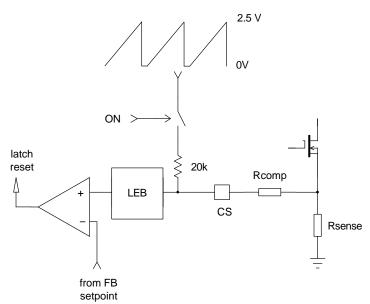


Figure 47. Inserting a Resistor in Series with the Current Sense Information Brings Ramp Compensation and Stabilizes the Converter in CCM Operation.

In the NCP1251 controller, the oscillator ramp features a 2.5 V swing reached at a 80% duty-ratio. If the clock operates at a 65 kHz frequency, then the available oscillator slope corresponds to:

$$S_{ramp} = \frac{V_{ramp,peak}}{D_{max}T_{SW}} = \frac{2.5}{0.8 \times 15\mu}$$

$$= 208 \text{ kV/s or } 208 \text{ mV/}\mu\text{s}$$
(eq. 10)

In our flyback design, let's assume that our primary inductance L_p is 770 μ H, and the SMPS delivers 19 V with a $N_p:N_s$ ratio of 1:0.25. The off–time primary current slope S_p is thus given by:

$$S_p = \frac{\left(V_{out} + V_f\right)\frac{N_p}{N_s}}{L_p} = \frac{(19 + 0.8) \times 4}{770\mu} = 103 \text{ kA/s}_{(eq. 11)}$$

Given a sense resistor of 330 m Ω , the above current ramp turns into a voltage ramp of the following amplitude:

$$S_{sense} = S_p R_{sense} = 103k \times 0.33$$

= 34 kV/s or 34 mV/ μ s

If we select 50% of the downslope as the required amount of ramp compensation, then we shall inject a ramp whose slope is 17 mV/ μ s. Our internal compensation being of 208 mV/ μ s, the divider ratio (*divratio*) between R_{comp} and the internal 20 k Ω resistor is:

divratio =
$$\frac{17\text{m}}{208\text{m}}$$
 = 0.082 (eq. 13)

The series compensation resistor value is thus:

$$R_{comp} = R_{ramp} \cdot divratio = 20k \times 0.082 \approx 1.6 k\Omega$$
 (eq. 14)

A resistor of the above value will then be inserted from the sense resistor to the current sense pin. We recommend adding a small capacitor of 100 pF, from the current sense

pin to the controller ground for an improved immunity to the noise. Please make sure both components are located very close to the controller.

Latching Off the Controller

The OPP pin not only allows a reduction of the peak current set point in relationship to the line voltage, it also offers a means to permanently latch-off the part. When the part is latched-off, the V_{CC} pin is internally pulled down to around 7 V and the part stays in this state until the user cycles the V_{CC} down and up again, e.g. by un-plugging the converter from the mains outlet. It is important to note that the SCR maintains its latched state as long as the injected current stays above the minimum value of 30 µA. As the SCR delatches for an injected current below this value, it is the designer duty to make sure the injected current is high enough at the lowest input voltage. Failure to maintain a sufficiently high current would make the device auto recover. A good design practice is to ensure at least 60 µA at the lowest input voltage. The latch detection is made by observing the OPP pin by a comparator featuring a 3 V reference voltage. However, for noise reasons and in particular to avoid the leakage inductance contribution at turn off, a 1 µs blanking delay is introduced before the output of the OVP comparator is checked. Then, the OVP comparator output is validated only if its high-state duration lasts a minimum of 600 ns. Below this value, the event is ignored. Then, a counter ensures that 4 successive OVP events have occurred before actually latching the part. There are several possible implementations, depending on the needed precision and the parameters you want to control.

The first and easiest solution is the additional resistive divider on top of the OPP one. This solution is simple and inexpensive but requires the insertion of a diode to prevent disturbing the OPP divider during the on time.

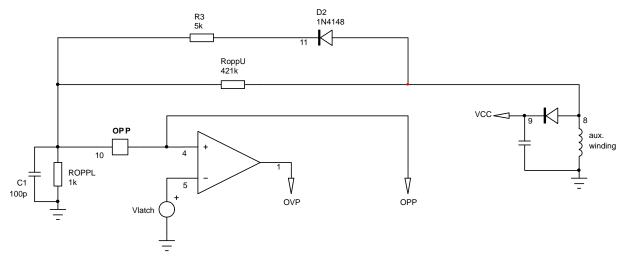


Figure 48. A Simple Resistive Divider Brings the OPP Pin Above 3 V in Case of a V_{CC} Voltage Runaway above

First, calculate the OPP network with the above equations. Then, suppose we want to latch off our controller when V_{out} exceeds 25 V. On the auxiliary winding, the plateau reflects the output voltage by the turns ratio between the power and the auxiliary winding. In case of voltage runaway for our 19 V adapter, the plateau will go up to:

$$V_{aux,OVP} = 25 \times \frac{0.18}{0.25} = 18 \text{ V}$$
 (eq. 15)

Since our OVP comparator trips at a 3 V level, across the $1 \text{ k}\Omega$ selected OPP pulldown resistor, it implies a 3 mA current. From 3 V to go up to 18 V, we need an additional 15 V. Under 3 mA and neglecting the series diode forward drop, it requires a series resistor of:

$$R_{OVP} = \frac{V_{latch} - V_{VOP}}{V_{OVP}/R_{OPPl}} = \frac{18 - 3}{3/1k} = \frac{15}{3m} = 5 \text{ k}\Omega \text{ (eq. 16)}$$

In nominal conditions, the plateau establishes to around 14 V. Given the divide—by—6 ratio, the OPP pin will swing to 14/6 = 2.3 V during normal conditions, leaving 700 mV margin. A 100 pF capacitor can be added between the OPP pin and GND to improve noise immunity and avoid erratic trips in presence of external surges. Do not increase this capacitor too much otherwise the OPP signal will be affected by the integrating time constant.

A second solution for the OVP detection alone, is to use a Zener diode wired as recommended by.

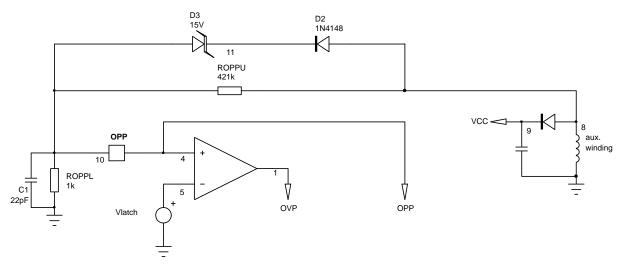


Figure 49. A Zener Diode in Series with a Diode Helps to Improve the Noise Immunity of the System

For this configuration to maintain an 18 V level, we have selected a 15 V Zener diode. In nominal conditions, the voltage on the OPP pin is almost 0 V during the off time as the Zener is fully blocked. This technique clearly improves the noise immunity of the system compared to that obtained from a resistive string as in Figure 48. Please note the reduction of the capacitor on the OPP pin to 10 pF - 22 pF. This capacitor is necessary because of the potential spike coupling through the Zener parasitic capacitance from the bias winding due to the leakage inductance. Despite the 1 μ s blanking delay at turn off. This spike is energetic enough to charge the added capacitor C_1 and given the time constant, could make it discharge slower, potentially disturbing the blanking circuit. When implementing the Zener option, it is important to carefully observe the OPP pin voltage (short

probe connections!) and check that enough margin exists to that respect.

Over Temperature Protection

In a lot of designs, the adapter must be protected against thermal runaways, e.g. when the temperature inside the adapter box increases above a certain value. Figure 50 shows how to implement a simple OTP using an external NTC and a series diode. The principle remains the same: make sure the OPP network is not affected by the additional NTC hence the presence of this isolation diode. When the NTC resistance decreases as the temperature increases, the voltage on the OPP pin during the off time will slowly increase and, once it passes 3 V for 4 consecutive clock cycles, the controller will permanently latch off.

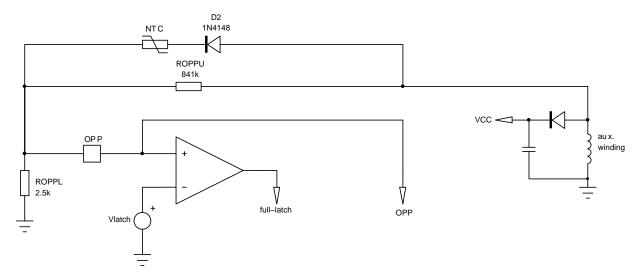


Figure 50. The Internal Circuitry Hooked to Pin 3 Can Be Used to Implement Over Temperature Protection (OTP)

Back to our 19 V adapter, we have found that the plateau voltage on the auxiliary diode was 13 V in nominal conditions. We have selected an NTC which offers a resistance of 470 k Ω at 25°C and drops to 8.8 k Ω at 110°C. If our auxiliary winding plateau is 14 V and we consider a 0.6 V forward drop for the diode, then the voltage across the NTC in fault mode must be:

$$V_{NTC} = 14 - 3 - 0.6 = 10.4 V$$
 (eq. 17)

Based on the 8.8 k Ω NTC resistor at 110 °C, the current through the device must be:

$$I_{NTC} = \frac{10.4}{8.8k} \approx 1.2 \text{ mA}$$
 (eq. 18)

As such, the bottom resistor $R_{\mbox{\scriptsize OPPL}}$, can easily be calculated:

$$R_{OPPL} = \frac{3}{1.2m} = 2.5 \text{ k}\Omega$$
 (eq. 19)

Now that the pulldown OPP resistor is known, we can calculate the upper resistor value R_{OPPU} to adjust the power

limit at the chosen output power level. Suppose we need a 200 mV decrease from the 0.8 V set point and the on–time swing on the auxiliary anode is -67.5 V, then we need to drop over R_{OPPU} a voltage of:

$$V_{ROPPU} = 67.5 - 0.2 = 67.3 V$$
 (eq. 20)

The current flowing in the pulldown resistor R_{OPPL} in this condition will be:

$$I_{ROPPU} = \frac{200m}{2.5k} = 80 \,\mu\text{A}$$
 (eq. 21)

The R_{OPPU} value is therefore easily derived:

$$R_{OPPU} = \frac{67.3}{80\mu} = 841 \text{ k}\Omega$$
 (eq. 22)

Combining OVP and OTP

The OTP and Zener-based OVP can be combined together as illustrated by Figure 51.

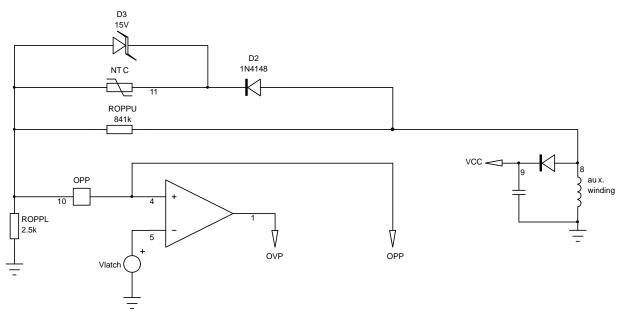


Figure 51. With the NTC Back in Place, the Circuit Nicely Combines OVP, OTP and OPP on the Same Pin

In nominal V_{CC} / output conditions, when the Zener is not activated, the NTC can drive the OPP pin and trigger the adapter in case of an over temperature. During nominal temperature if the loop is broken, the voltage runaway will be detected and the controller will shut down the converter.

In case the OPP pin is not used for either OPP or OVP, it can simply be grounded.

Filtering the Spikes

The auxiliary winding is the seat of spikes that can couple to the OPP pin via the parasitic capacitances exhibited by the Zener diode and the series diode. To prevent an adverse triggering of the Over Voltage Protection circuitry, it is possible to install a small *RC* filter before the detection

network. Typical values are those given in Figure 52 and must be selected to provide the adequate filtering function without degrading the stand-by power by an excessive current circulation.

Latched OVP on V_{CC}

The V_{CC} pin is permanently monitored by a comparator. When the V_{CC} exceeds 25.5 V (typical), all pulses are immediately stopped and the V_{CC} falls to the SCR latched-level around 7 V typical. The controller remains in this state as long as a sufficient current flows in the SCR, at least 30 μ A. We recommend to put a design margin there, with a minimum current around 60 μ A at the lowest input line. With the C version, the OVP on V_{CC} is autorecovery.

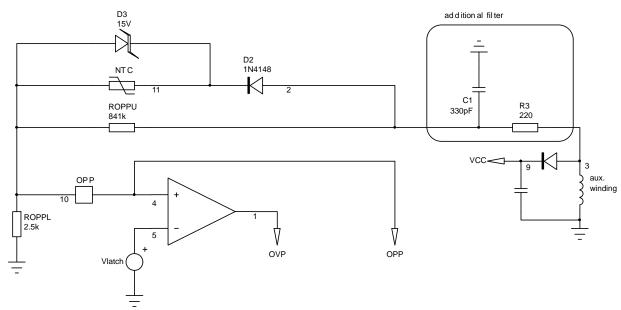


Figure 52. A Small *RC* Filter Avoids the Fast Rising Spikes from Reaching the Protection Pin of the NCP1251 in Presence of Energetic Perturbations Superimposed on the Input Line



2. SOURCE 2

DRAIN 2

5. SOURCE 1

DRAIN 1

3. GATE 2

TSOP-6 CASE 318G-02 **ISSUE V**

DATE 12 JUN 2012

STYLE 6: PIN 1. COLLECTOR 2. COLLECTOR 3. BASE 4. EMITTER 5. COLLECTOR 6. COLLECTOR

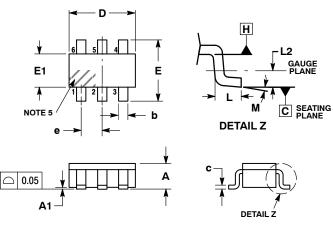
> 2. GROUND 3. I/O 4. I/O 5. VCC 6. I/O

STYLE 12:

NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
- CONTROLLING DIMENSION: MILLIMETERS.
 MAXIMUM LEAD THICKNESS INCLUDES LEAD FINISH. MINIMUM
- 3. MAXIMUM LEAD I HICKNESS INCOURS LEAD FINISH. MINIMUM THICKNESS OF BASE MATERIAL.
 4. DIMENSIONS D AND E1 DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS, MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL NOT EXCEED 0.15 PER SIDE. DIMENSIONS D AND E1 ARE DETERMINED AT DATUM H.
 5. PIN ONE INDICATOR MUST BE LOCATED IN THE INDICATED ZONE.

	MILLIMETERS				
DIM	MIN	NOM	MAX		
Α	0.90	1.00	1.10		
A1	0.01	0.06	0.10		
b	0.25	0.38	0.50		
С	0.10	0.18	0.26		
D	2.90	3.00	3.10		
Е	2.50	2.75	3.00		
E1	1.30	1.50	1.70		
е	0.85	0.95	1.05		
L	0.20	0.40	0.60		
L2	0.25 BSC				
NA.	00 400				



2. DRAIN 3. GATE 4. SOURCE	 COLLECTOR 1 EMITTER 1 	PIN 1. ENABLE 2. N/C 3. R BOOST 4. Vz 5. V in	2. V in 3. NOT USED 4. GROUND	 COLLECTOR 1 EMITTER 1
STYLE 7: PIN 1. COLLECTOR 2. COLLECTOR 3. BASE 4. N/C 5. COLLECTOR 6. EMITTER	PIN 1 Vhus	STYLE 9: PIN 1. LOW VOLTAGE GATE 2. DRAIN 3. SOURCE 4. DRAIN 5. DRAIN 6. HIGH VOLTAGE GATE	PIN 1 D(OLIT)+	PIN 1. SOURCE 1 2. DRAIN 2 3. DRAIN 2 4. SOURCE 2 5. GATE 1
STYLE 13: PIN 1 GATE 1	STYLE 14:		.E 16:	STYLE 17: PIN 1 FMITTER

2. SOURCE

DRAIN

6. CATHODE

3. GATE

5. N/C

RECOMMENDED SOLDERING FOOTPRINT*

CATHODE/DRAIN

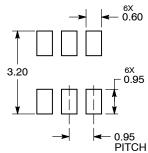
CATHODE/DRAIN

CATHODE/DRAIN

SOURCE

3. GATE

5.

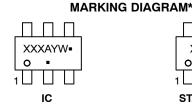


DIMENSIONS: MILLIMETERS

CATHODE COLLECTOR **GENERIC**

3. ANODE/CATHODE

2. BASE





XXX = Specific Device Code

Α =Assembly Location Υ = Year

= Work Week = Pb-Free Package XXX = Specific Device Code

M = Date Code = Pb-Free Package

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.

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2. BASE

5. ANODE

3. EMITTER

COLLECTOR

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